International Rectifier

- Generation V Technology
- Ultra Low On-Resistance
- N-Channel Mosfet
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

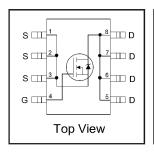
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

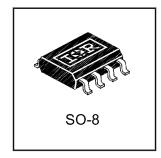
The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

IRF7401PbF

HEXFET® Power MOSFET



$$V_{DSS} = 20V$$
 $R_{DS(on)} = 0.022\Omega$



Absolute Maximum Ratings

	3					
	Parameter	Max.	Units			
I _D @ T _A = 25°C	10 Sec. Pulsed Drain Current, V _{GS} @ 4.5V	10				
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 4.5V	8.7				
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 4.5V	7.0	A			
I _{DM}	Pulsed Drain Current ①	35				
P _D @T _A = 25°C	Power Dissipation	2.5	W			
	Linear Derating Factor	0.02	W/°C			
V_{GS}	Gate-to-Source Voltage	± 12	V			
dv/dt	Peak Diode Recovery dv/dt ②	5.0	V/ns			
$T_{J,}T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	°C			

Thermal Resistance Ratings

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient⊕		50	°C/W

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250\mu A$	
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.044		V/°C	Reference to 25°C, I _D = 1mA	
D	Static Drain-to-Source On-Resistance			0.022	Ω	$V_{GS} = 4.5V, I_D = 4.1A$ ③	
R _{DS(ON)}	Static Dialii-to-Source Oil-Resistance			0.030	52	$V_{GS} = 2.7V, I_D = 3.5A$ ③	
$V_{GS(th)}$	Gate Threshold Voltage	0.70			V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
g _{fs}	Forward Transconductance	11			S	$V_{DS} = 15V, I_D = 4.1A$	
	Duain to Course Lealers Commant			1.0	μA	$V_{DS} = 16V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source Leakage Current			25	μΑ	V_{DS} = 16V, V_{GS} = 0V, T_{J} = 125 °C	
loos	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 12V	
I _{GSS}	Gate-to-Source Reverse Leakage			-100	11/	V _{GS} = -12V	
Qg	Total Gate Charge			48		I _D = 4.1A	
Q _{gs}	Gate-to-Source Charge			5.1	nC	V _{DS} = 16V	
Q_{gd}	Gate-to-Drain ("Miller") Charge			20		V_{GS} = 4.5V, See Fig. 6 and 12 ③	
t _{d(on)}	Turn-On Delay Time		13			V _{DD} = 10V	
t _r	Rise Time		72		no	I _D = 4.1A	
t _{d(off)}	Turn-Off Delay Time		65		ns	$R_G = 6.0\Omega$	
t _f	Fall Time		92			R_D = 2.4 Ω , See Fig. 10 ③	
L _D	Internal Drain Inductance	—	2.5		nH	Between lead tip	
L _S	Internal Source Inductance		4.0			and center of die contact	
C_{iss}	Input Capacitance		1600			V _{GS} = 0V	
Coss	Output Capacitance		690		pF	V _{DS} = 15V	
C _{rss}	Reverse Transfer Capacitance		310			f = 1.0MHz, See Fig. 5	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I_S	Continuous Source Current			2.4	Α	MOSFET symbol
	(Body Diode)			3.1		showing the
I _{SM}	Pulsed Source Current			0.5	^	integral reverse
	(Body Diode) ①		_	35		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.0	V	$T_J = 25$ °C, $I_S = 2.0$ A, $V_{GS} = 0$ V ③
t _{rr}	Reverse Recovery Time		39	59	ns	$T_J = 25$ °C, $I_F = 4.1A$
Q _{rr}	Reverse RecoveryCharge		42	63	nC	di/dt = 100A/μs ③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} \textcircled{2} & I_{SD} \leq 4.1A, \ di/dt \leq 100A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ & T_{J} \leq 150 \ensuremath{^{\circ}C} \ensuremath{^{\circ}} \ensuremath{^{$

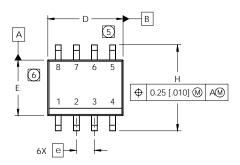
IRF7401PbF

International

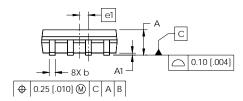
TOR Rectifier

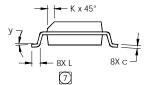
SO-8 Package Outline

Dimensions are shown in millimeters (inches)



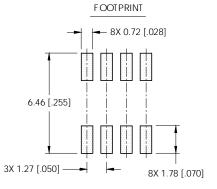
DIM	INC	HES	MILLIMETERS			
DIIVI	MIN	MAX	MIN	MAX		
Α	.0532	.0688	1.35	1.75		
A1	.0040	.0098	0.10	0.25		
b	.013	.020	0.33	0.51		
С	.0075	.0098	0.19	0.25		
D	.189	.1968	4.80	5.00		
Е	.1497	.1574	3.80	4.00		
е	.050 B	ASIC	1.27 B	1.27 BASIC		
e1	.025 BASIC		0.635 E	BASIC		
Н	.2284	.2440	5.80	6.20		
K	.0099	.0196	0.25	0.50		
L	.016	.050	0.40	1.27		
У	0°	8°	0°	8°		





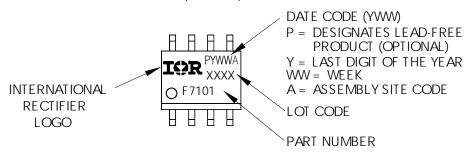
NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: MILLIMETER
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- (5) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
- (6) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
- [7] DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



SO-8 Part Marking

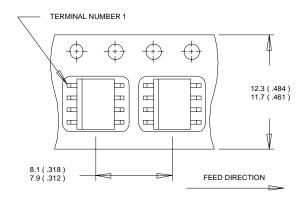
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



IRF7401PbF

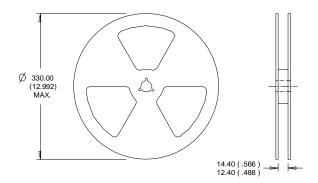
SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
 - Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

